

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

2SC3405

SWITCHING REGULATOR AND HIGH VOLTAGE SWITCHING APPLICATIONS

INDUSTRIAL APPLICATIONS

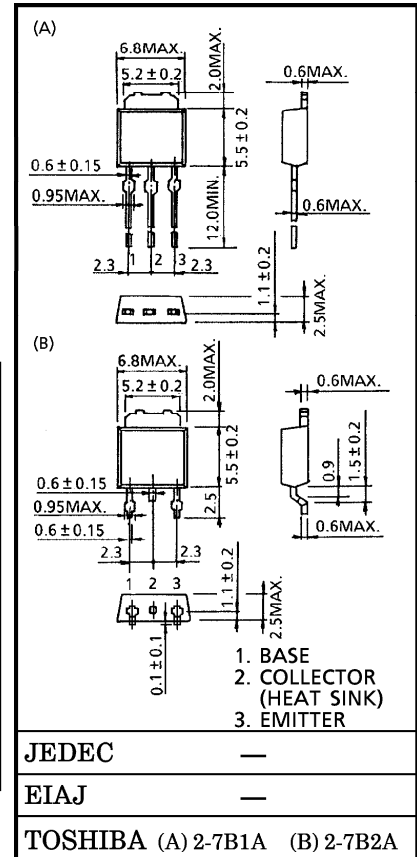
HIGH SPEED DC-DC CONVERTER APPLICATIONS

Unit in mm

- Excellent Switching Times ($I_C = 0.3\text{ A}$)
: $t_r = 1.0\ \mu\text{s}$ (Max.), $t_f = 1.0\ \mu\text{s}$ (Max.)
- High Collector Breakdown Voltage : $V_{CEO} = 800\text{ V}$

MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	900	V
Collector-Emitter Voltage	V_{CEO}	800	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	DC	I_C	0.8
	Pulse	I_{CP}	1.5
Base Current	I_B	0.2	A
Collector Power Dissipation	$T_a = 25^\circ\text{C}$	P_C	1.0
	$T_c = 25^\circ\text{C}$		20
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55~150	$^\circ\text{C}$



Weight : 0.36 g

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		ICBO	V _{CB} = 800 V, I _E = 0	—	—	100	μA
Emitter Cut-off Current		IEBO	V _{EB} = 8 V, I _C = 0	—	—	1	mA
Collector-Base Breakdown Voltage		V _{(BR) CBO}	I _C = 1 mA, I _E = 0	900	—	—	V
Collector-Emitter Breakdown Voltage		V _{(BR) CEO}	I _C = 10 mA, I _B = 0	800	—	—	V
DC Current Gain		h _{FE} (1)	V _{CE} = 5 V, I _C = 1 mA	6	—	—	
		h _{FE} (2)	V _{CE} = 5 V, I _C = 0.3 A	10	—	—	
Collector-Emitter Saturation Voltage		V _{CE} (sat)	I _C = 0.3 A, I _B = 0.06 A	—	—	0.5	V
Base-Emitter Saturation Voltage		V _{BE} (sat)	I _C = 0.3 A, I _B = 0.06 A	—	—	1.2	V
Switching Time	Rise Time	t _r	<p> $I_{B1} = -I_{B2} = 0.06 \text{ A}$, DUTY CYCLE $\leq 1\%$ </p>	—	—	1.0	μs
	Storage Time	t _{stg}		—	—	4.0	
	Fall Time	t _f		—	—	1.0	

